Sparch Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/697,146	CHO ET AL.
Examiner	Art Unit

2874

Search Notes	10/697,146
	Examiner
	PHAN T.H. PALMER

SEARCHED				
Class	Subclass	Date	Examiner	
385	15, 24, 33-39	5/10/2005	PTHP	
· · · · · · · · · · · · · · · · · · ·		-		
			-	
	_			
		 - -		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
385	24, 33	5/12/2005	PTHP	
		-		
	1			
	•			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST SEARCHING DATA IN FILE	5/12/2005	PTHP	